Tracking in 4-Dimension

Is it possible to build a tracker with concurrent excellent time and position resolution?

Can we provide in one detector, or in combination

Timing resolution ~ 10 ps Space resolution ~ 10's of μm





The effect of timing information

The inclusion of track-timing in the event information has the capability of changing radically how we design experiments.

Timing can be available at different levels of the event reconstruction.

- 1) Timing at each point along the track
- 2) Timing in the event reconstruction
- 3) Timing at the trigger level

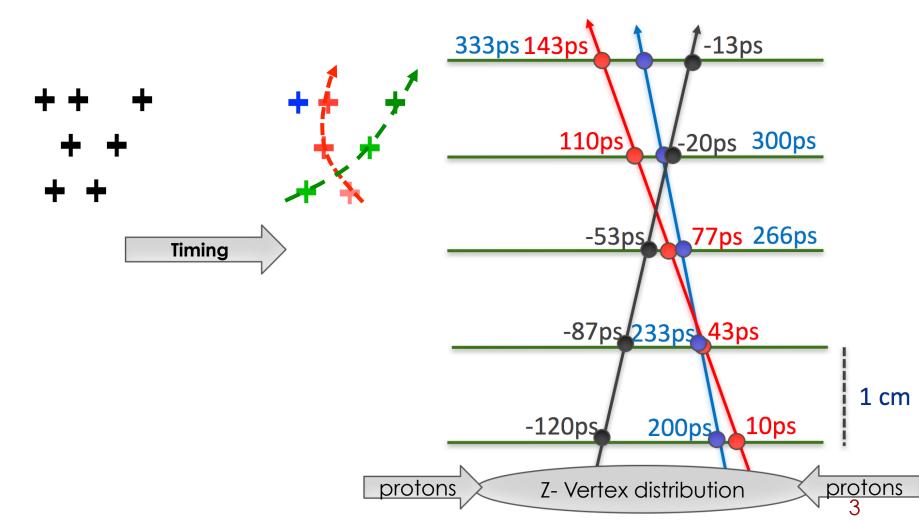
INN

- EPS Venice 07/07/17

Cartiglia, INFN, Torino

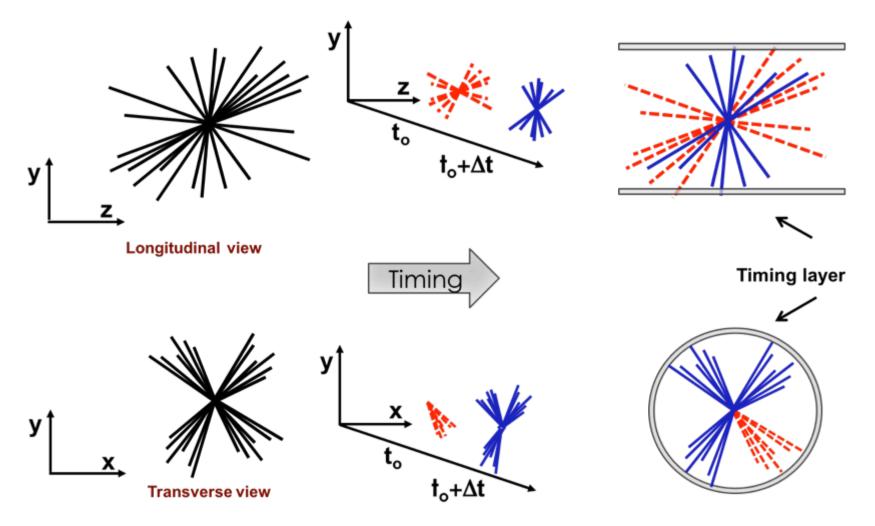
Timing at each point along the track

→Massive simplification of patter recognition, new tracking algorithms will be faster even in very dense environments
 → Use only "time compatible points"



Timing in the event reconstruction

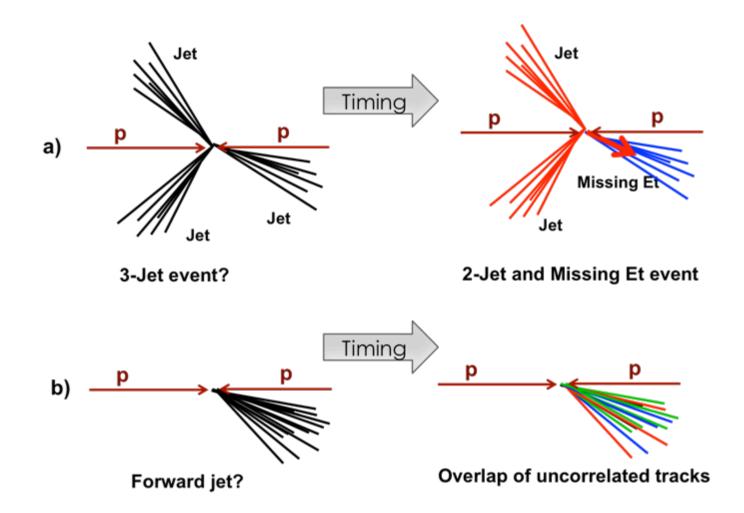
Timing allows distinguishing overlapping events by means of an extra dimension.



INEN

Timing in the trigger

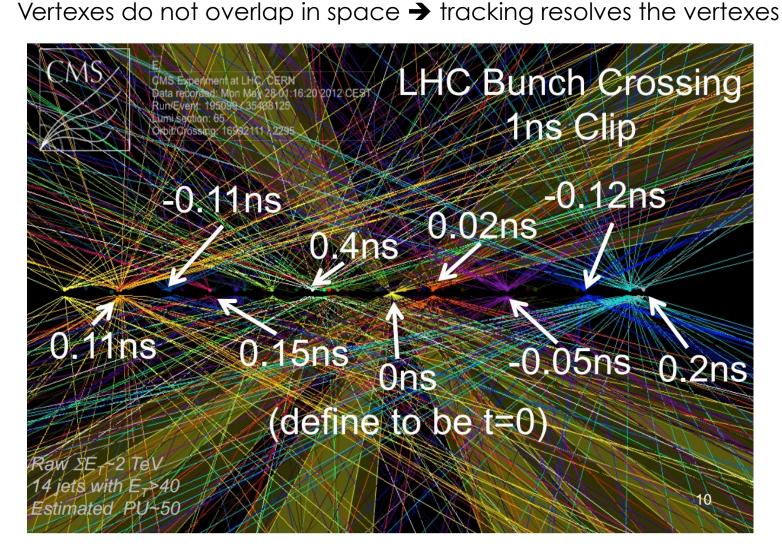
Timing at the trigger decision: it allows reducing the trigger rate, rejecting topologies that look similar, but they are actually different.



IN EN

Vertexes in space and time

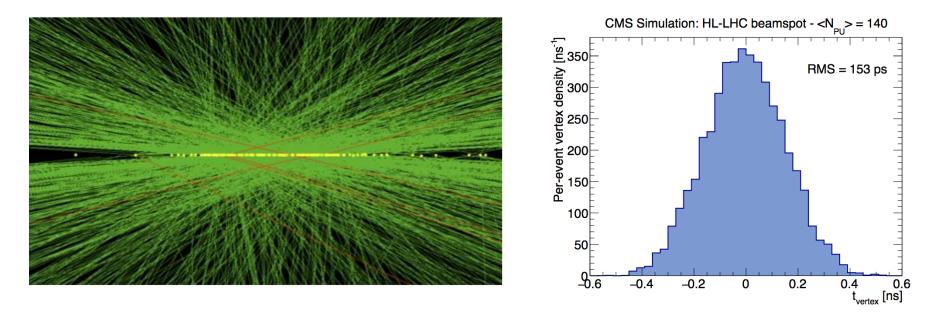
CMS Current situation, pile-up \sim 50:



Vertexes in space and time

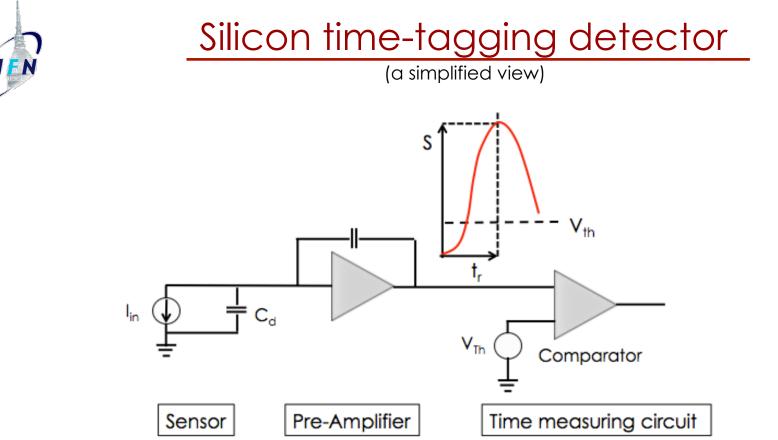
HL-LHC situation, pile-up \sim 150 - 200:

Vertexes overlap in space → tracking does not resolves all vertexes



There are between 15-20% of tracking vertexes (longitudinal resolution ~ 200 micron) that are actually composed by 2 or more interactions

 \rightarrow Loss of events \rightarrow loss of luminosity



Time is set when the signal crosses the comparator threshold

The timing capabilities are determined by the characteristics of the signal at the output of the pre-Amplifier and by the TDC binning.

Strong interplay between sensor and electronics



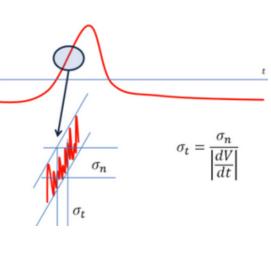
Time resolution

 $\sigma_{t} = (\frac{N}{dV/dt})^{2} + (Landau Shape)^{2} + TDC$

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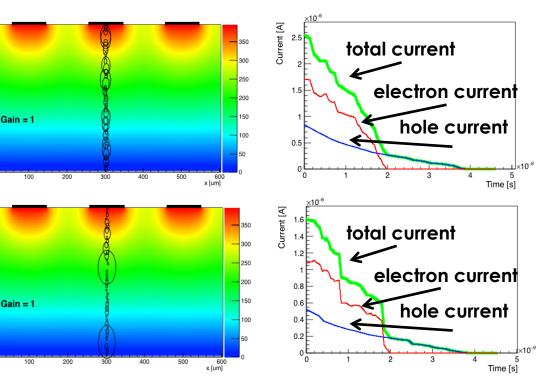
Usual "Jitter" term Here enters everything that is "Noise" and the steepness of the signal

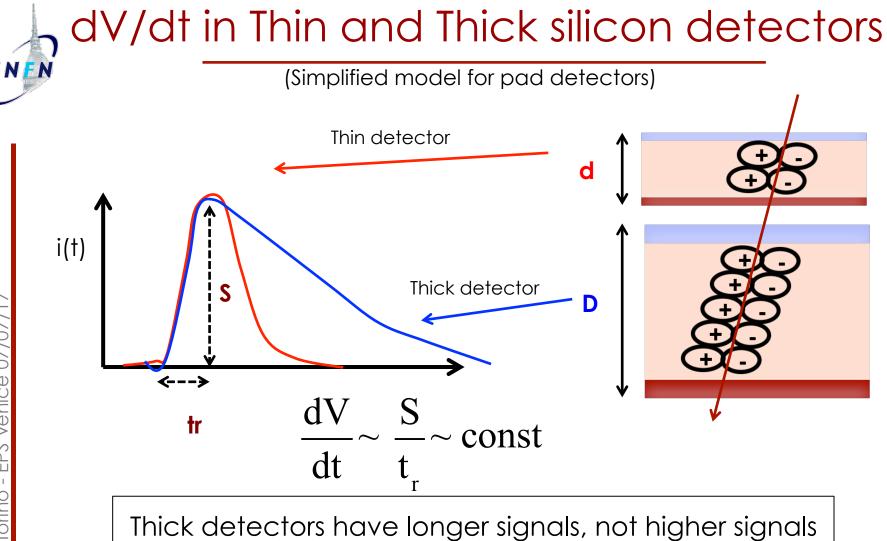


Need large dV/dt

Time walk: Amplitude variation, corrected in electronics

Shape variations: non homogeneous energy



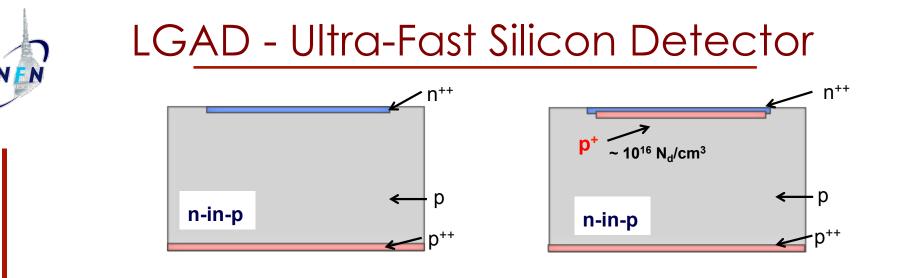


Best result : NA62, 150 ps on a 300 x 300 micron pixels

How can we do better?

→ Add internal gain

Gain need E ~ 300kV/cm. How can we do it? INFN 1) Use external bias: assuming a 50 micron silicon detector, we need V_{bigs} = ~ 600 - 700 kV ~ 75 pairs/µm $v_d \sim 100 \mu m/ns$ d Difficult to achieve 2) Use Gauss Theorem: $\sum q = 2\pi r * E$ E = 300 kV/cm → q ~ 10¹⁶ /cm³ Need to have 10¹⁶/cm³ charges !!



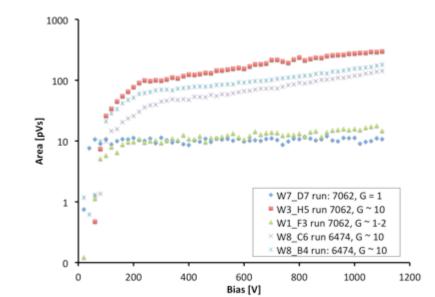
Traditional silicon detector

Low gain avalanche detectors

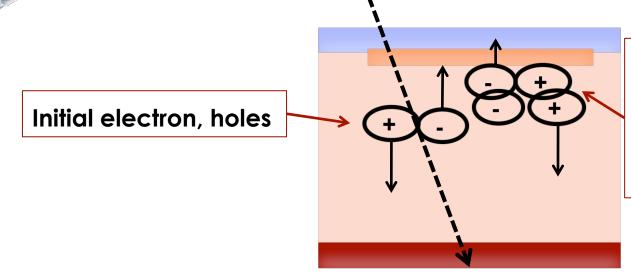
Adding a highly doped, thin layer of of p-implant near the p-n junction creates a high electric field that accelerates the electrons enough to start multiplication. Same principle of APD, but with much lower gain.

Gain changes very smoothly with bias voltage.

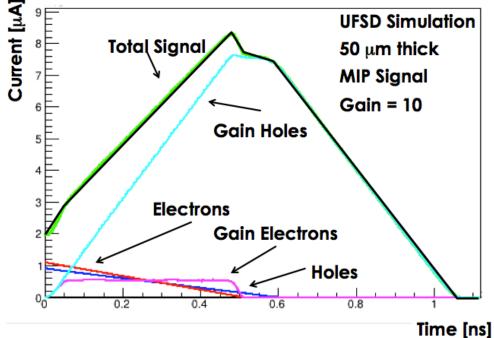
Easy to set the value of gain requested.



How gain shapes the signal



Gain electron: absorbed immediately Gain holes: long drift home

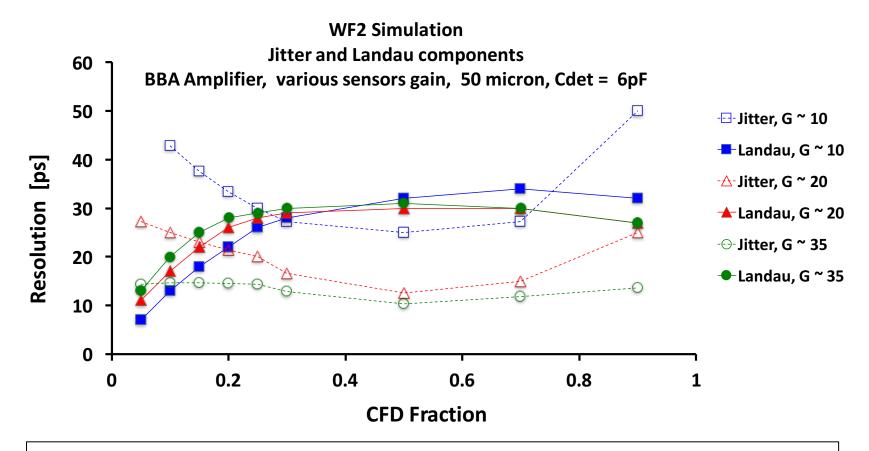


Electrons multiply and produce additional electrons and holes.

- Gain electrons have almost no effect
- Gain holes dominate the signal

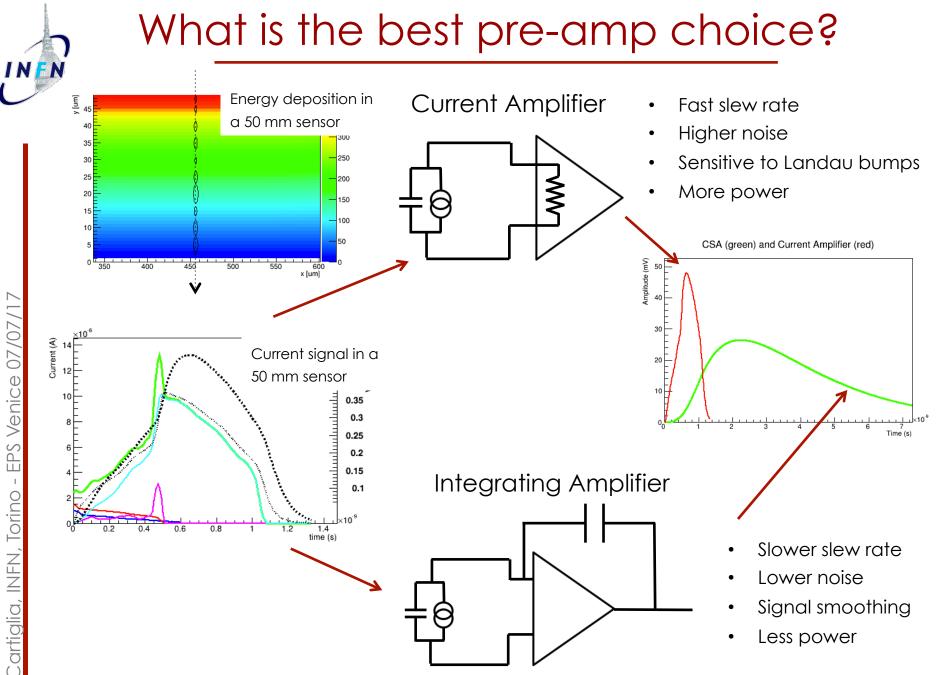
No holes multiplications

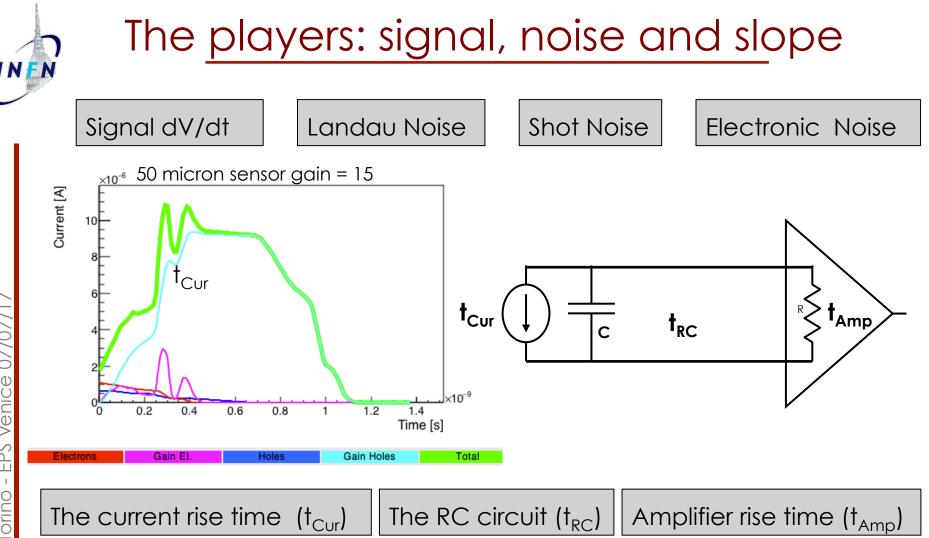
How precise can we be with 50-micron thick sensors?



Two main contributions: Jitter and charge non uniformity

- Jitter (empty symbols) can be lowered with gain
- Charge non uniformity (solid symbol) limits the ultimate precision





There are 3 quantities determining the output rise time after the amplifier:

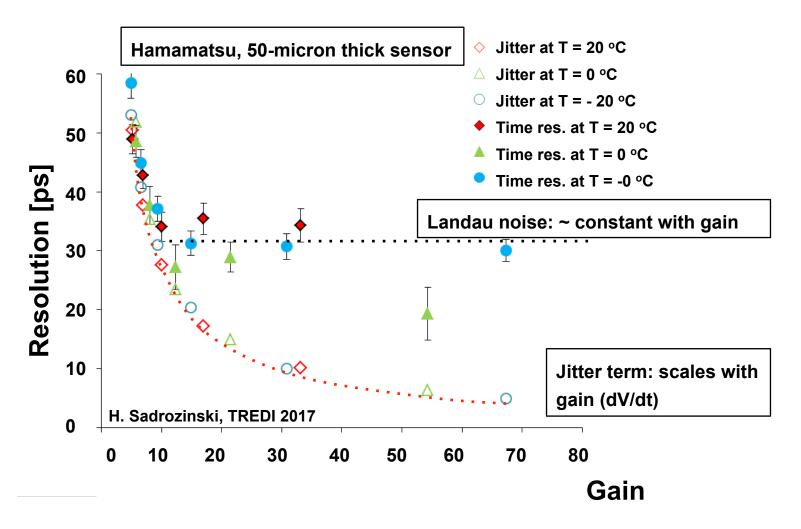
- 1. The signal rise time (t_{Cur})
- 2. The RC circuit formed by the detector capacitance and the amplifier input impedance ($t_{\rm RC}$)
- 3. The amplifier rise time (t_{Amp})

Sensors: FBK & CNM

FBK 50-micron production CNM 75-micron Very successful, good gain and CNM 50-micron production overall behavior Gain layer: Boron, Gallium, x3 TOTEM x4 CT-PPS Boron+Carbon, Gallium+Carbon ATLAS High Granularity Timing Det. UECD 0

UFSD time resolution

UFSD from Hamamatsu confirm our simulation: 30 ps time resolution, Value of gain ~ 20





Irradiation effects

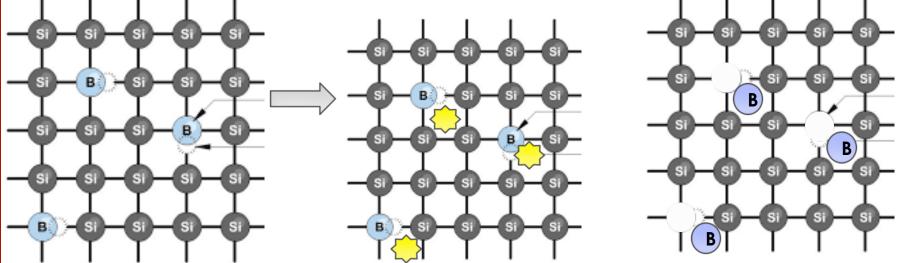
Irradiation causes 3 main effects:

- Decrease of charge collection efficiency due to trapping
 → Very small in thin sensor
- Increased leakage current, shot noise → back up slides
- Gain layer disappearance → following slides

Radiation issue: Initial acceptor removal

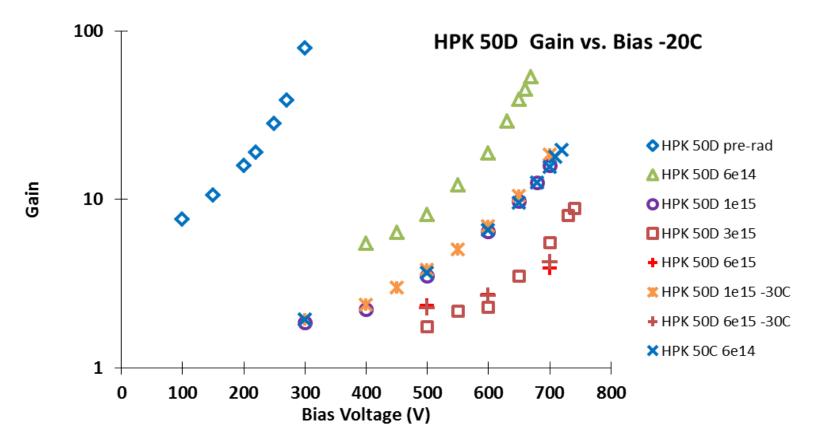
This term indicates the "removal" of the initially present p-doping. For UFSD this is particularly problematic as it removes the gain layer

Irradiation -> Defects -> Boron becomes interstitial



The boron doping is still there, only it has been moves into a different position and it does not contribute to the doping profile, it is inactive

Gain in for irradiated sensors

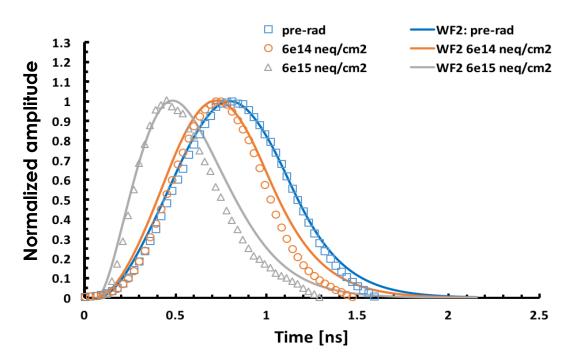


No unexpected features: the gain layer disappearance is compensated by external bias



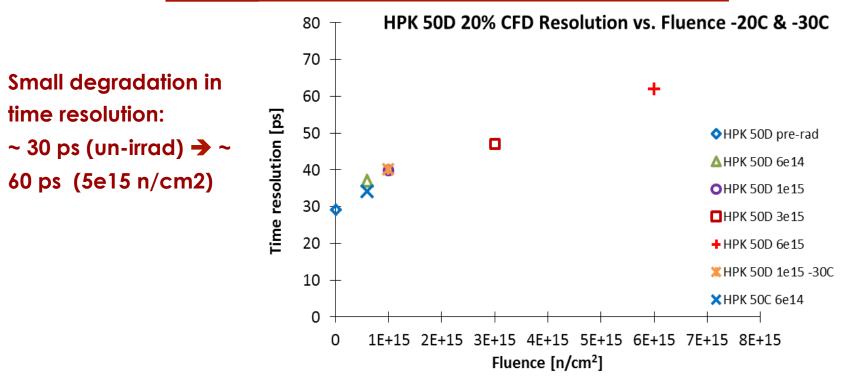
Pulse shape in irradiated UFSD

Comparison measured - WF2 pulse of HPK 50D 50micron thick sensors



With irradiation the signal changes: it becomes shorter and steeper

Time resolution of irradiated sensors



Can we do better? Probably...

We are now starting to test Gallium, Boron + Carbon and Gallium + Carbon. By fall 2017 we will know if any of these tricks helps

Note: the above plot is made with a constant CFD threshold (20%).

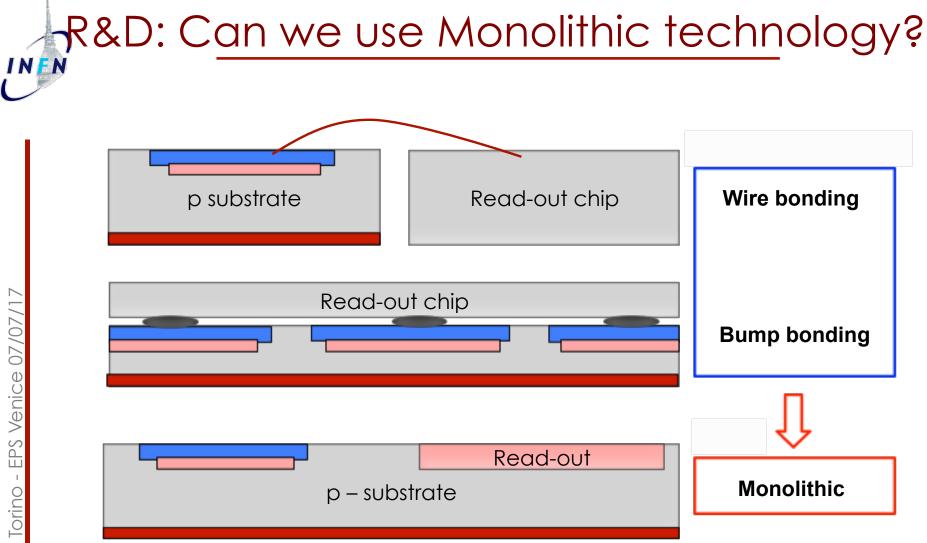
→ Better results if we can change it during the sensors' lifetime

A read-out chip for UFSD sensors

Basic characteristics:

- → Amplifier + comparator + TDC (CFD; ToT+ToA or both)
- → Bump bonded (or similar) to the sensor
- → Input charge range up to 20 fC (gain ~ 40)
- → Measure MIP timing with ~ 20 ps precision (not to spoil UFSD precision)
- → Low power

We have started the R&D on dedicated front-end chip fro track timing





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Ministere degli Affari Esteri e della Cooperazione Internazionale

DIREZIONE GENERALE PER LA PROMOZIONE DEL SISTEMA PAESE Unità per la cooperazione scientifica <u>e</u> tecnologica bilaterale e multilaterale

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Summary

4 Dimensional tracking opens up new opportunities in detector design.

The use of timing at each point in a tracking system allows using much simpler reconstruction algorithm, and allow higher particle densities.

Timing at the track level allows reconstructing the event properties without the effect of pile-up.

4-D tracking can be achieved using special silicon sensors with internal gain, the so called UFSD design based on the LGAD technology

Sensor R&D is very active, funded by a variety of sources. Very strong collaboration ATLAS-CMS.

Best time resolution is ~ 30 ps (gain ~ 20 with CFD ~ 20%) when new, and ~ 50 ps (gain ~ 7-10 with CFD ~ 50%) at 1e15neq/cm2